

SiC Mosfet

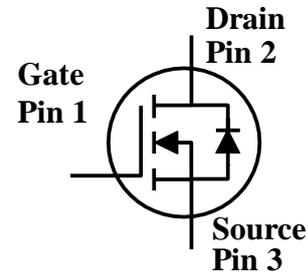
Features:

- High Voltage, Low On-State Resistance
- High Speed, Low Parasitic Capacitance
- High Operating Junction Temperature
- Fast Recovery Body Diode

Applications:

- Photovoltaic Inverter
- UPS Power Supply
- Motor Drive
- High-Voltage DC/DC Converters
- Switching Power Supply

Package:



Product Code	Package
SL19N120A	TO-247-3

Maximum Ratings (T_c=25°C, unless otherwise specified)

Symbol	Parameter description	Typical value	Unit	Testing conditions	Note
V _{DS}	Drain-Source Voltage	1200	V	V _{GS} =0V, I _D =100μA	
V _{GS}	Gate-Source Voltage	-5 to 20	V	The device is recommended working within the voltage range listed above.	
I _D	Maximum Drain-Source Current	19	A	V _{GS} =20V, T _c =25°C	Figure 21
		14	A	V _{GS} =20V, T _c =100°C	
I _{DM}	Maximum Pulse Drain-Source Current	48	A	It depends on the safe operating area (SOA) of the device.	Figure 24
P _{TOT}	Maximum Power Dissipation	134	W	T _c =25°C	Figure 22
T _{stg}	Storage Temperature Range	-55 to 175	°C		
T _j	Operating Junction Temperature Range	-55 to 175	°C		
T _L	Soldering Temperature	260	°C	Wave Soldering is done on the lead, 1.6mm away from the package housing, and it lasts for no more than 10 seconds	

Thermal-Resistance Property

Symbol	Parameter description	Typical value	Unit	Note
R _{θ(j-c)}	junction-to-case thermal resistance	1.122	°C/W	Figure 23

Electrical Property (TC = 25°C, unless otherwise specified)

Symbol	Parameter description	Code Value			Unit	Testing conditions	Note
		MIN	Typical	MAX			
I _{DSS}	Drain Leakage At Shutdown		5	100	μA	V _{DS} =1200V, V _{GS} =0V	
I _{GSS}	Gate Induced Drain Leakage		1	±100	nA	V _{DS} =0V, V _{GS} =-5~20V	
V _{TH}	Threshold Voltage		2.9		V	V _{GS} =V _{DS} , I _D =1.9mA	Figure 8, 9
			1.9			V _{GS} =V _{DS} , I _D =1.9mA @ T _C =175°C	
R _{ON}	On-State Resistance		160	195	mΩ	V _{GS} =20V, I _D =10A @ T _J =25°C	Figure 4, 5, 6, 7
			285		mΩ	V _{GS} =20V, I _D =10A @ T _J =175°C	
C _{iss}	Input Capacitance		895		pF	V _{DS} =800V, V _{GS} =0V, f=1MHz, V _{AC} =25mV	Figure 16
C _{oss}	Output Capacitance		43		pF		
C _{rss}	Reverse Transfer Capacitance		2		pF		Figure 17
E _{oss}	Output Capacitance Storage Energy		4.2		μJ		
Q _g	Total Gate Charge		43		nC	V _{DS} =800V, I _D =10A, V _{GS} =-5 to 20V	Figure 18
Q _{gs}	Gate-Source Charge		9		nC		
Q _{gd}	Gate-Drain Charge		19		nC		
R _g	Gate Input Resistance		8.5		Ω	f=1MHz	
E _{ON}	Turn-on Energy		204		μJ	V _{DS} =800V, I _D =10A, V _{GS} =-2 to 20V, R _{G(ext)} =3.3Ω, L=450μH	Figure 19, 20
E _{OFF}	Turn-off Energy		34.4		μJ		
t _{d(on)}	Turn-on Delay Time		15.2		ns		
t _r	Rise Time		14.4				
t _{d(off)}	Turn-off Delay Time		11.3				
t _f	Fall Time		13.1				

Electrical Property (T_c=25°C, unless otherwise specified)

Symbol	Parameter description	Code Value			Unit	Testing conditions	Note
		MIN	Typical	MAX			
V _{SD}	Forward Voltage		4.1		V	I _{SD} =5A, V _{GS} =0V	Figure 10, 11, 12
			3.7		v	I _{SD} =5A, V _{GS} =0V, T _J =175°C	
t _{rr}	Reverse Recovery Time		33.2		ns	V _{GS} =-2V/+20V, I _{SD} =10A, V _R =800V, di/dt=1000A/us, R _{G(ext)} =13Ω	
Q _{rr}	Reverse Recovery Charge		101.5		nC		
I _{RRM}	Peak Repetitive Reverse Current		5.6		A		

Typical Characteristic Curves:

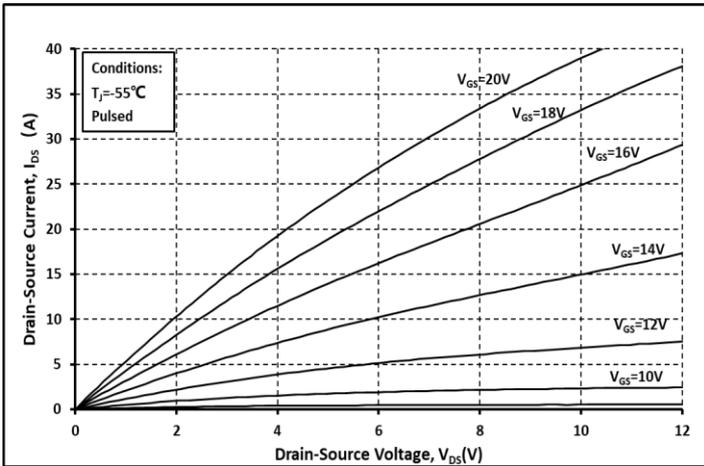


Figure. 1 Output @ $T_j = -55^\circ\text{C}$

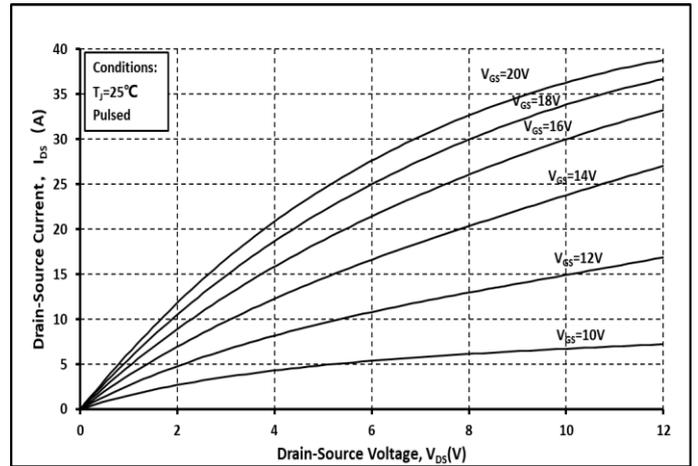


Figure. 2 Output @ $T_j = 25^\circ\text{C}$

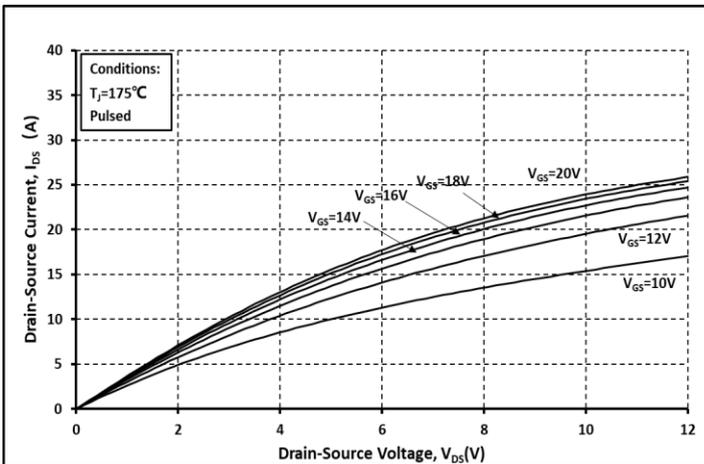


Figure. 3 Output @ $T_j = 175^\circ\text{C}$

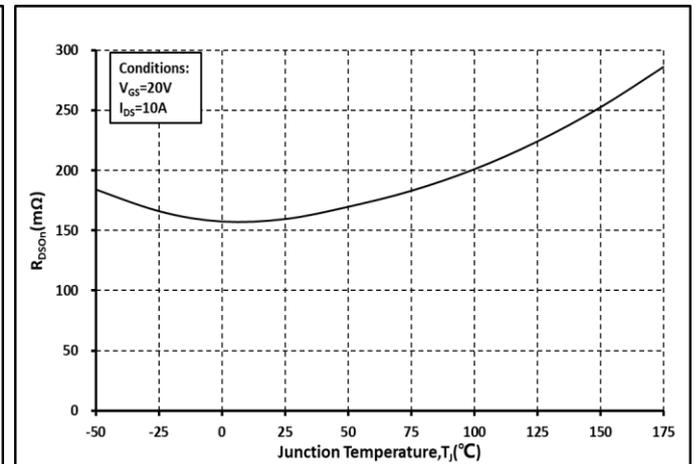


Figure. 4 R_{on} VS Temperature

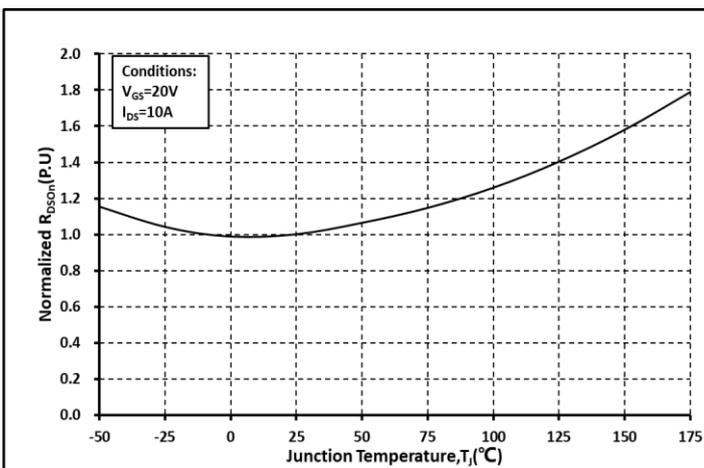


Figure. 5 Normalized R_{on} VS Temperature

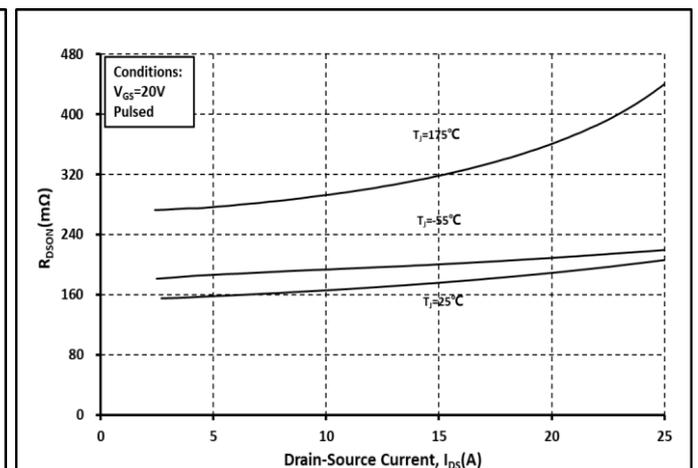


Figure. 6 R_{on} VS I_{DS} at Different Temperatures

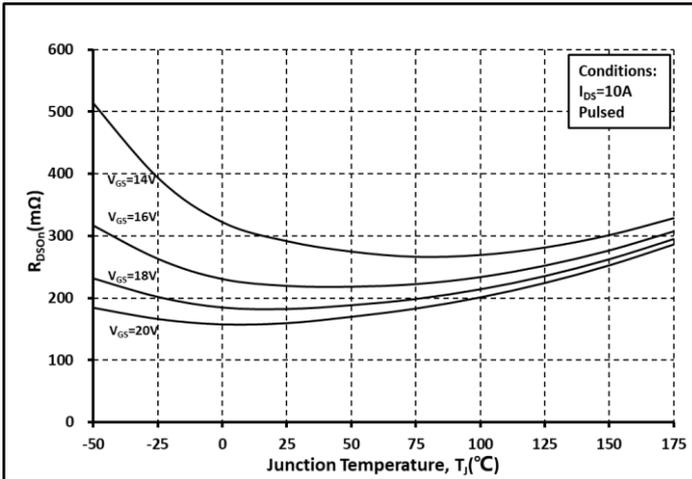


Figure. 7 Ron VS Temperature at Different VGS

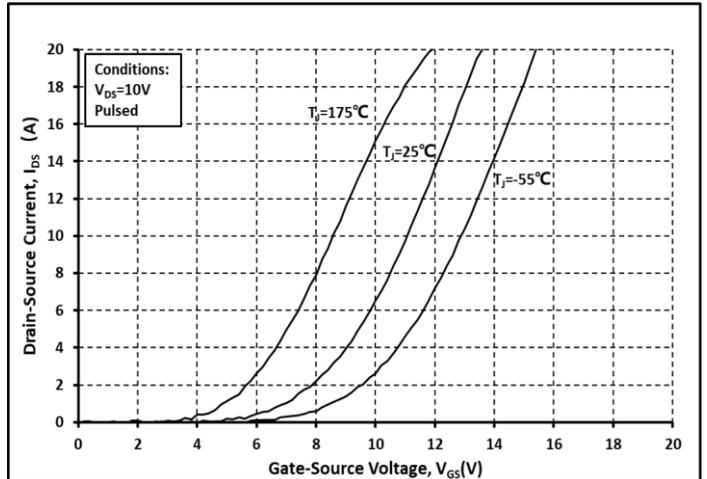


Figure. 8 Transfer Property at Different Temperatures

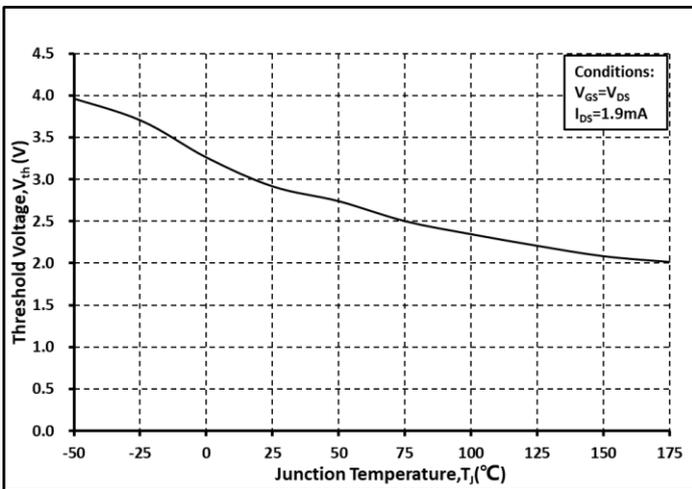


Figure. 9 Threshold Voltage Change With Temperature

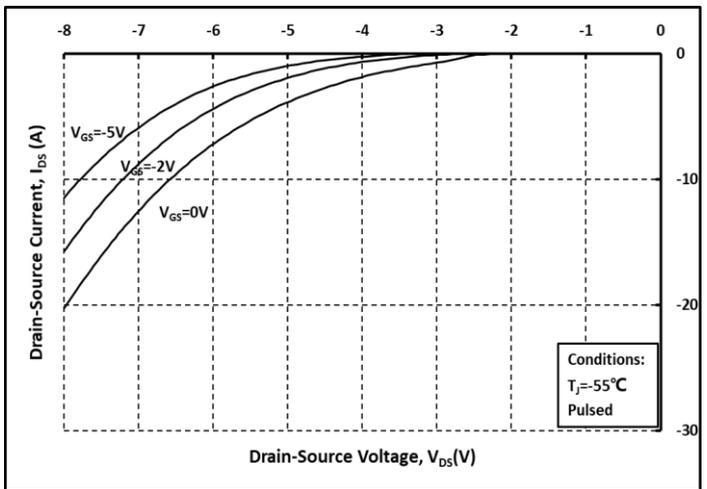


Figure. 10 Body Diode On-State @ $T_J = -55^{\circ}C$

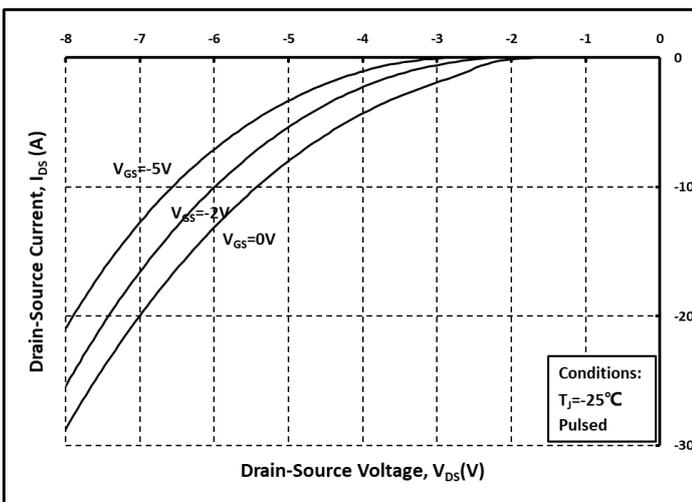


Figure. 11 Body Diode On-State @ $T_J=25^{\circ}C$

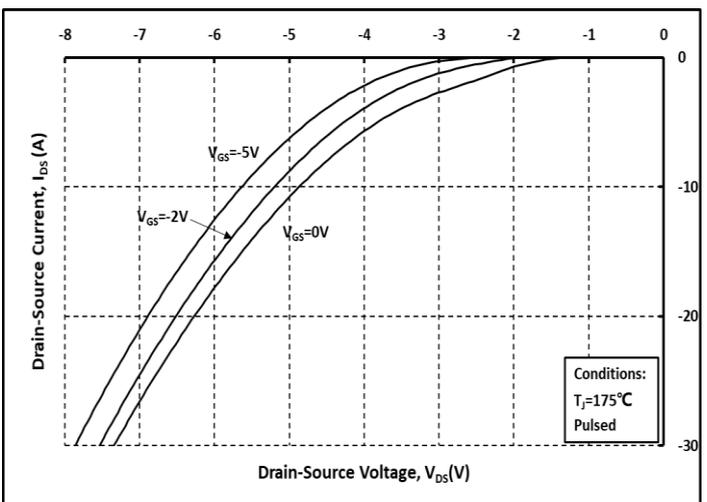


Figure. 12 Body Diode On-State @ $T_J=175^{\circ}C$

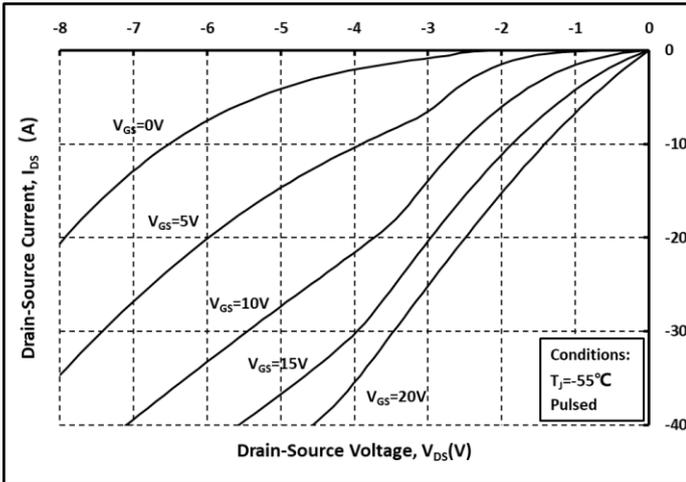


Figure. 13 Quadrant III @ $T_j = -55^\circ\text{C}$

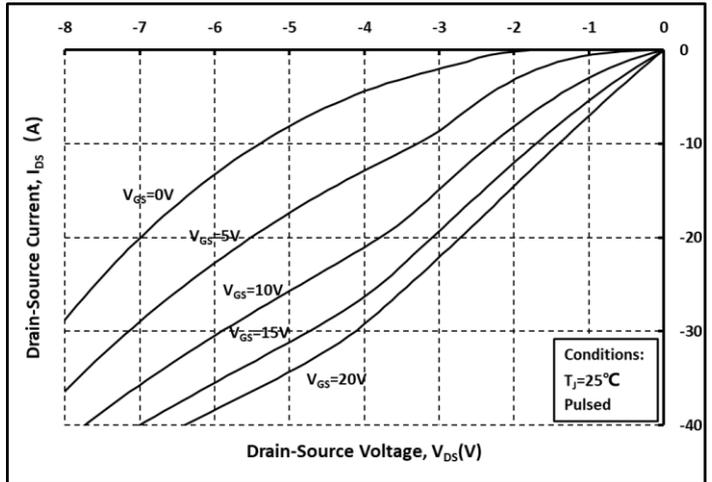


Figure. 14 Quadrant III @ $T_j = 25^\circ\text{C}$

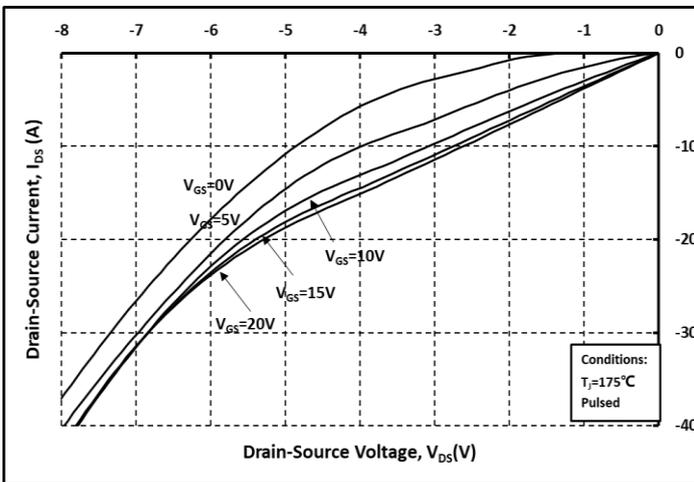


Figure. 15 Quadrant III @ $T_j = 175^\circ\text{C}$

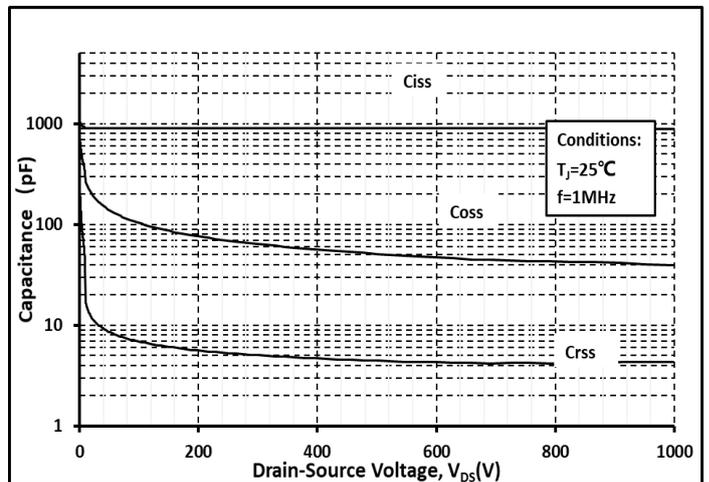


Figure. 16 Capacitances VS V_{DS}

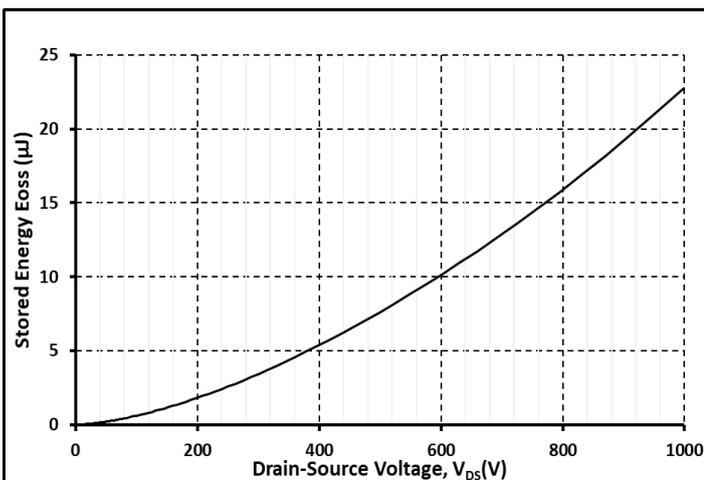


Figure. 17 Output Capacitance Storage

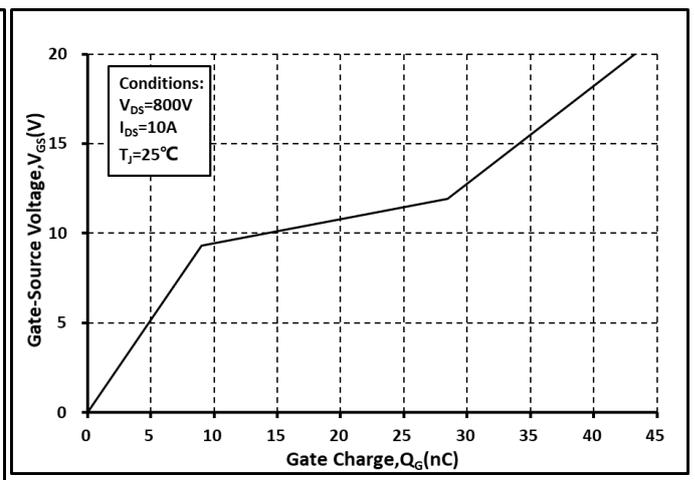


Figure. 18 Gate charge characteristic curve

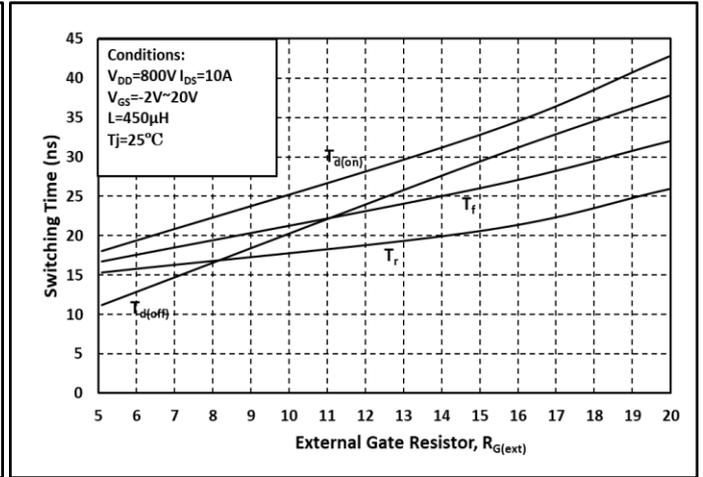
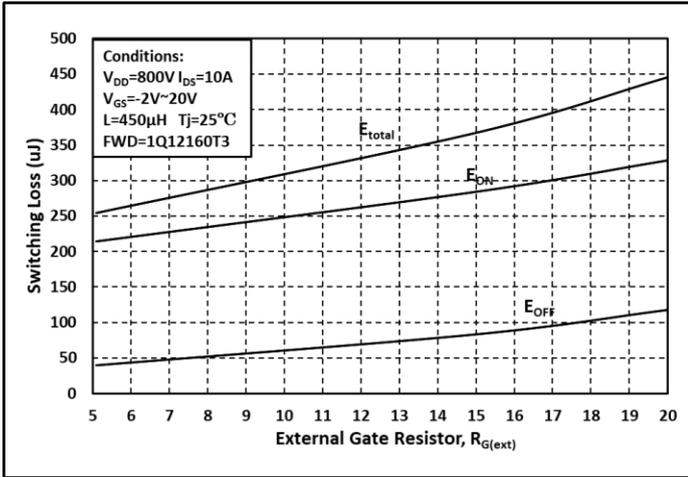


Figure. 19 Switching Energy VS Gate Resistance $R_{G(est)}$

Figure. 20 Switching Time VS Gate Resistance $R_{G(est)}$

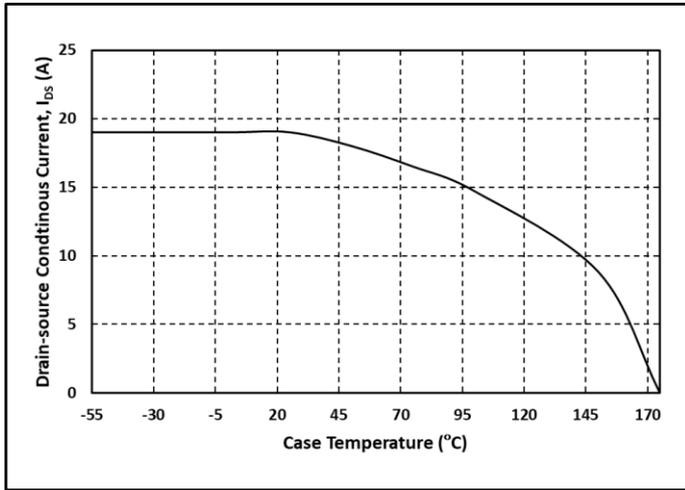


Figure. 21 Drain Current VS Temperature

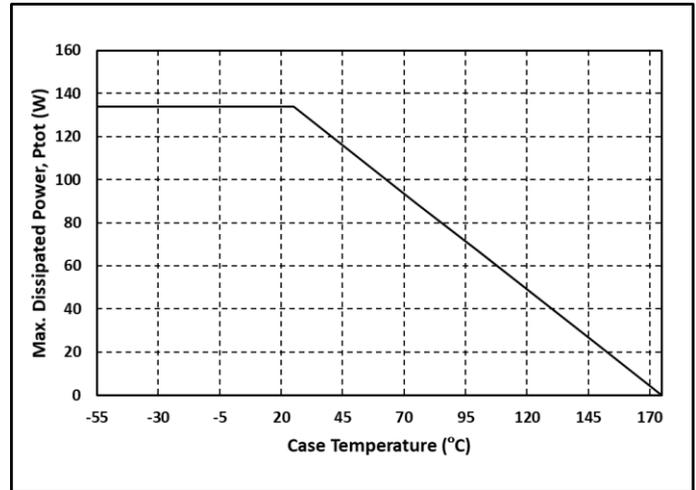


Figure. 22 Maximum Power Derating VS Temperature

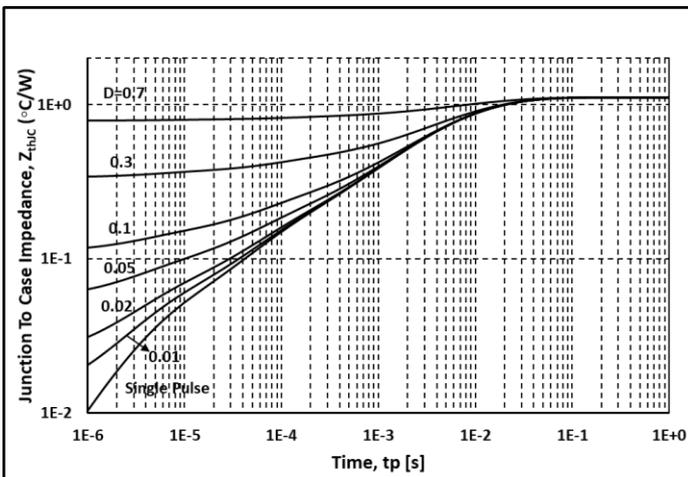


Figure. 23 Thermal Resistance

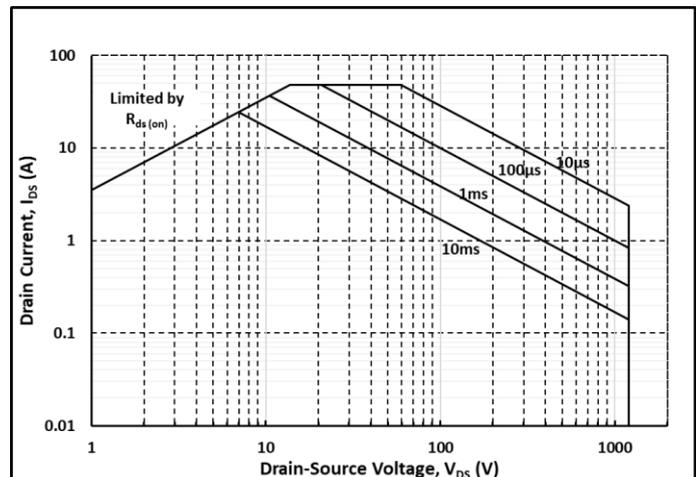
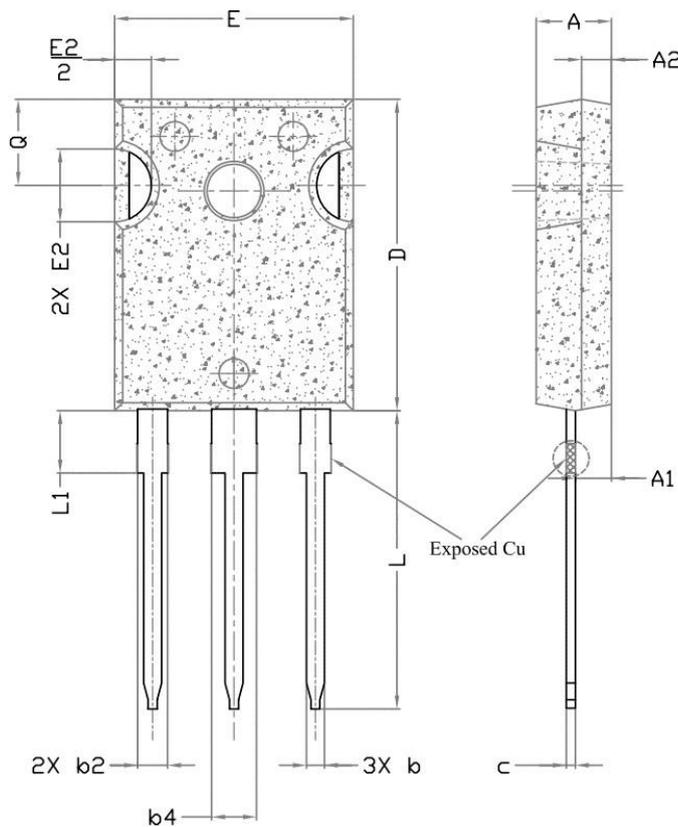
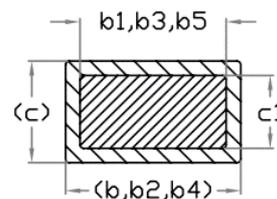
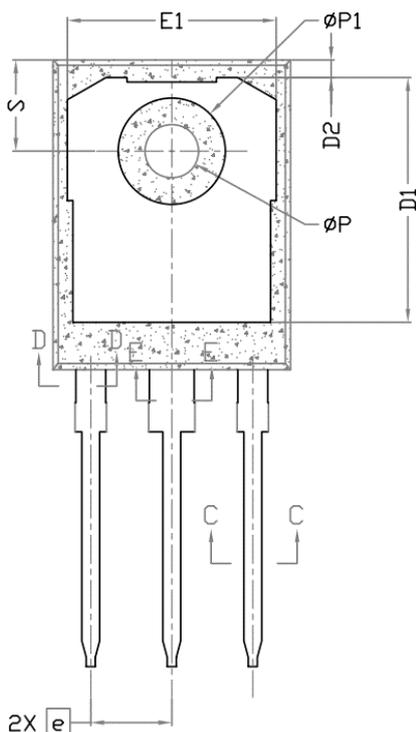


Figure. 24 The Safe Operating Area

Package Specification



SYMBOL	DIMENSIONS			NOTES
	MIN.	NOM.	MAX.	
A	4.83	5.02	5.21	
A1	2.29	2.41	2.55	
A2	1.50	2.00	2.49	
b	1.12	1.20	1.33	
b1	1.12	1.20	1.28	
b2	1.91	2.00	2.39	6
b3	1.91	2.00	2.34	
b4	2.87	3.00	3.22	6, 8
b5	2.87	3.00	3.18	
c	0.55	0.60	0.69	6
c1	0.55	0.60	0.65	
D	20.80	20.95	21.10	4
D1	16.25	16.55	17.65	5
D2	0.51	1.19	1.35	
E	15.75	15.94	16.13	4
E1	13.46	14.02	14.16	5
E2	4.32	4.91	5.49	3
e	5.44BSC			
L	19.81	20.07	20.32	
L1	4.10	4.19	4.40	6
ØP	3.56	3.61	3.65	7
ØP1	7.19REF.			
Q	5.39	5.79	6.20	
S	6.04	6.17	6.30	



Section C--C, D--D, E--E

Description:

1. Standard Reference: JEDEC TO247, Variation AD
2. Unit: mm
3. There shall be slots in it, and the shape can be round.
4. Mould overflowing is excluded from D and E.